

# SiPM irradiation 2022

**update**

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# 2022 irradiation plan

This was the baseline plan as discussed in February 2022

## test SiPM performance and annealing with increasing integrated NIEL

simulate a more realistic experimental situation

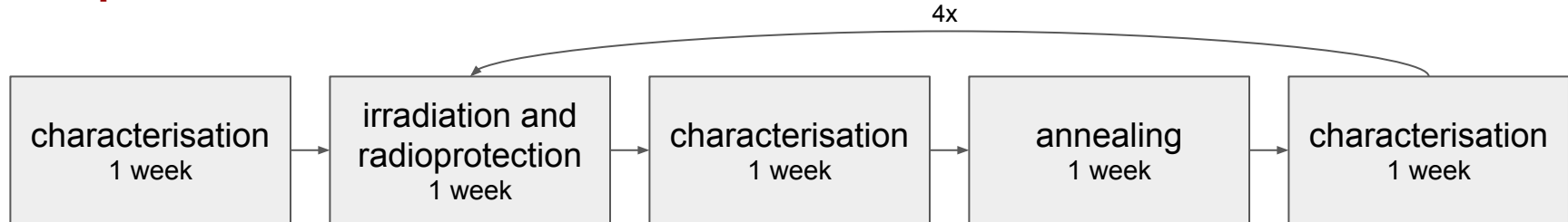
## irradiate full SiPM carrier boards with flat proton field

no collimators, this will make life much easier and very efficient use of beam

- **3 short accesses at TN protontherapy centre (TIFPA) in spring**

- ideally 4 hours on Saturdays, should be sufficient time to setup and fire the beam
- tentative dates: 23 April, 28 May and 2 July
- one access every 4-6 weeks: allow time for radioprotection, characterisation and annealing
- small NIEL integration steps, perhaps:  $1 \cdot 10^9$  ,  $2 \cdot 10^9$  ,  $4 \cdot 10^9$

- **plus 1 more access in fall**



# 2022 irradiation plan

some little changes down the way but mostly sticking to plan

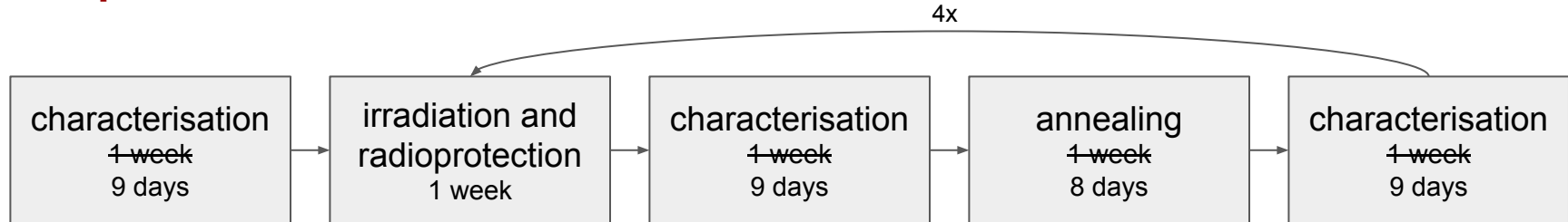
## test SiPM performance and annealing with increasing integrated NIEL

simulate a more realistic experimental situation

## irradiate full SiPM carrier boards with flat proton field

no collimators, this will make life much easier and very efficient use of beam

- **3 2 short accesses at TN protontherapy centre (TIFPA) in spring and summer**
  - ideally 4 hours on Saturdays, should be sufficient time to setup and fire the beam
  - ~~tentative dates: 23 April, 28 May and 2 July~~ actual dates: 4 June, 16 July
  - one access every 4-6 weeks: allow time for radioprotection, characterisation and annealing
  - small NIEL integration steps, perhaps:  $1 \cdot 10^9$ ,  ~~$2 \cdot 10^9$~~ ,  ~~$4 \cdot 10^9$~~   $1 \cdot 10^9$
- **plus 4 2 more accesses in fall: perhaps 5 Nov ( $1 \cdot 10^9$ ) and 3 Dec ( $2 \cdot 10^9$ )**





# Irradiation (4 hours slots at TIFPA / CPT / Trento)

- **keep it simple**

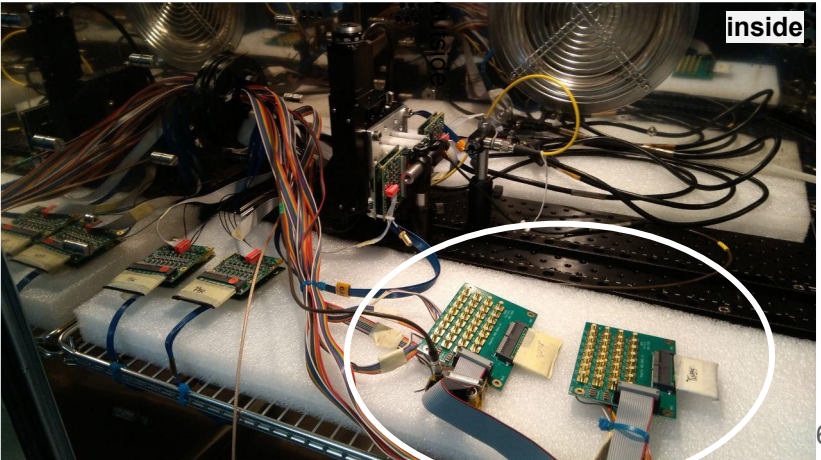
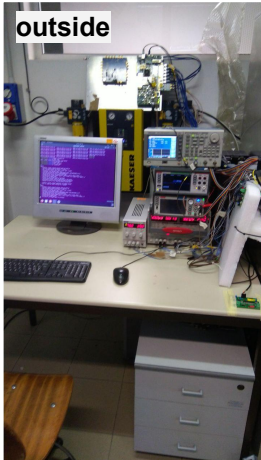
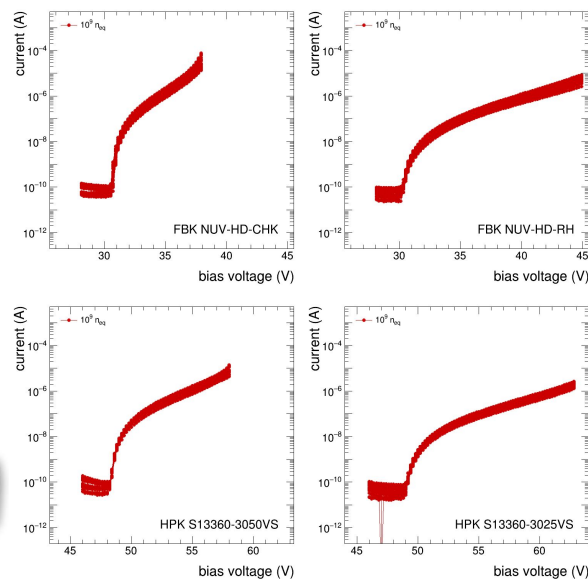
- large uniform irradiation field
  - no collimators
- proton flux at location  $\sim 5.5 \cdot 10^5 \text{ cm}^{-2} \text{ s}^{-1} \text{ nA}^{-1}$ 
  - typical irradiation: 14 nA for  $\sim 120 \text{ s}$
- bare boards with poor-man supports
  - one board at a time

- **nominal irradiation campaign**

- very fast beam setup thanks to experience of last year
- several boards with one  $10^9$  neq shot completes in  $\sim 1$  hour
- rest of beam time utilised for “annealing by Joule effect with direct bias current” exploration
  - split total  $10^9$  in 5 equal shots of  $2 \cdot 10^8$
  - interleaved with 30 minutes of annealing

# Current measurements

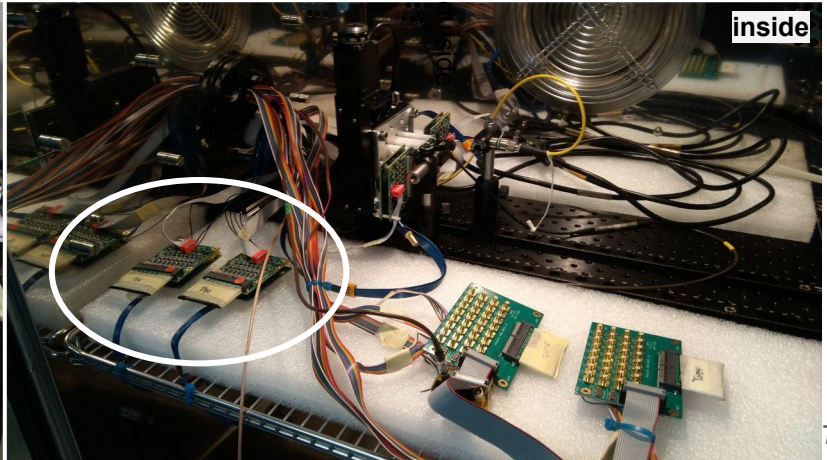
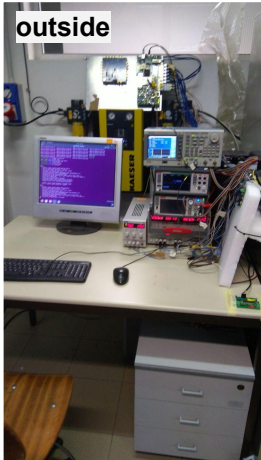
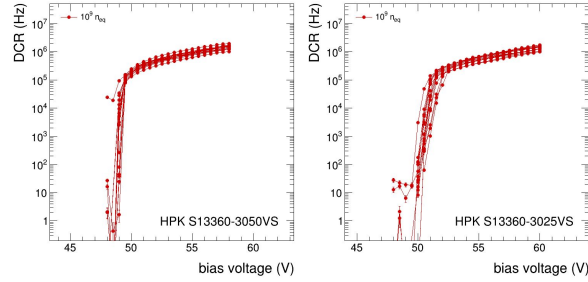
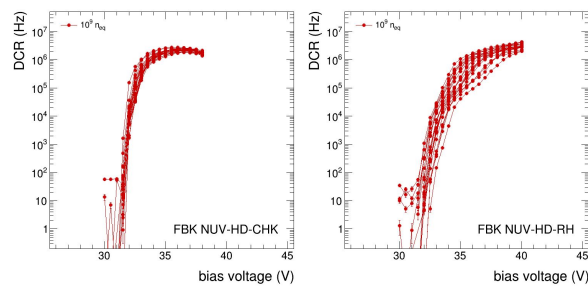
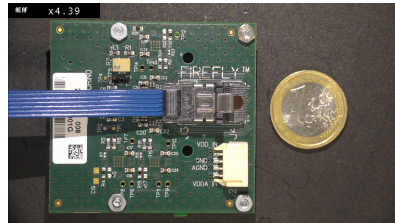
- **climatic chamber**  
low-temperature operation  
all reported measurements at  $T = -30\text{ }^{\circ}\text{C}$
- **2x 40-channel multiplexers**  
automatic measurement of 2x SiPM boards (64 channels)
- **source meter**





# DCR measurements

- **climatic chamber**  
low-temperature operation  
all reported measurements at  $T = -30\text{ }^{\circ}\text{C}$
- **2x ALCOR-based front-end chain**  
automatic measurement of 2x SiPM boards (64 channels)
- **FPGA (Xilinx) readout**



# Annealing (in the oven @ Ferrara)

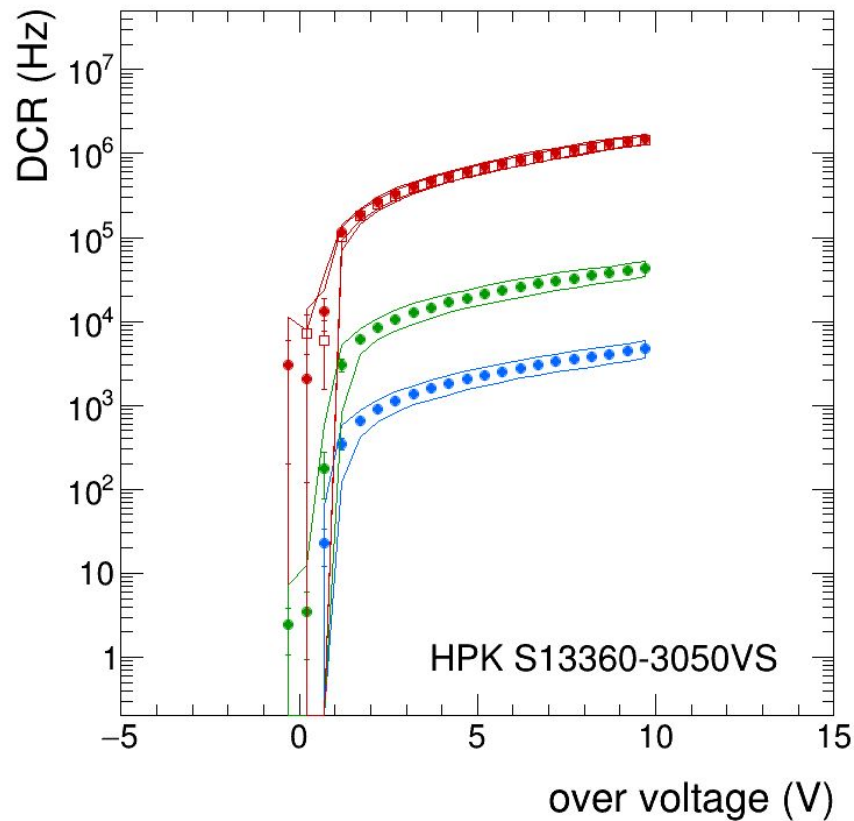
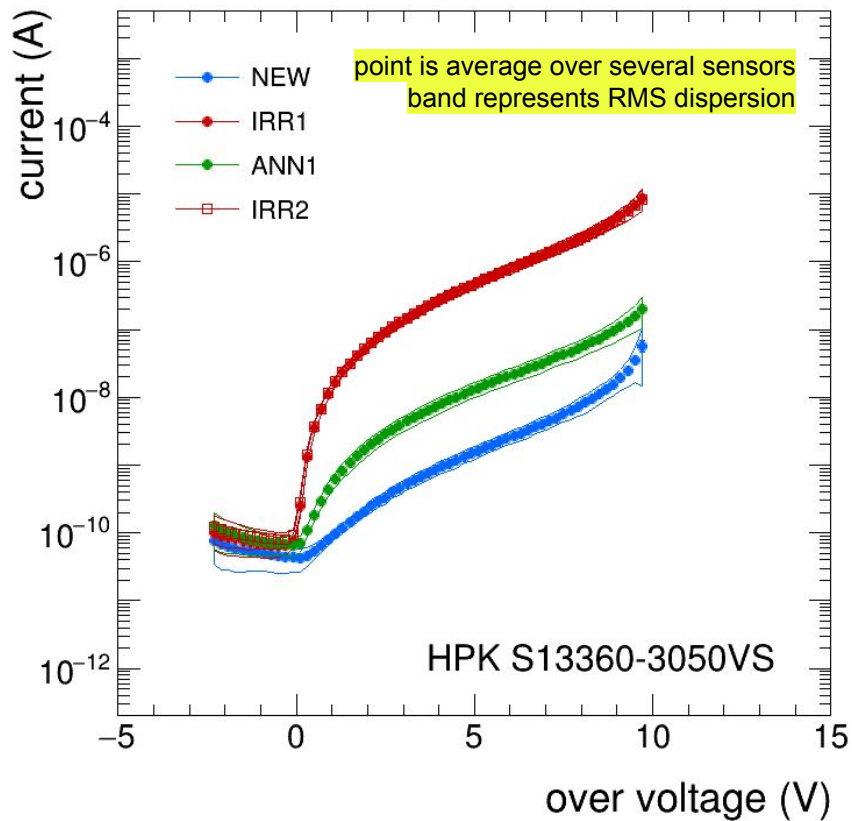
- **numbers**

- Temperature = 150 C
- Time = 150 hours

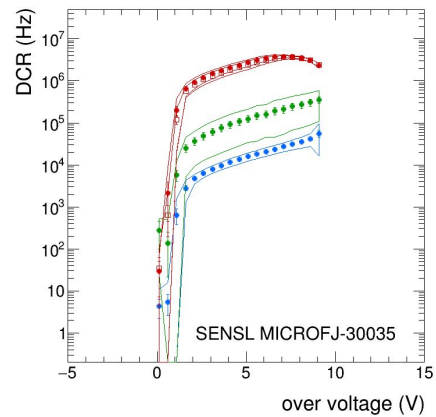
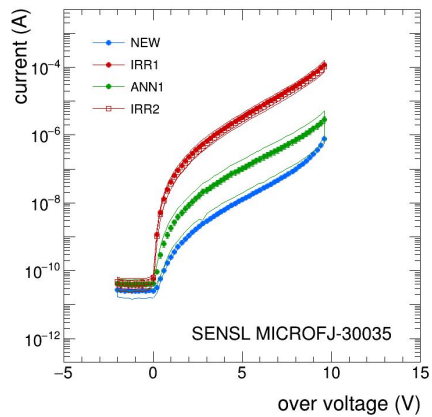
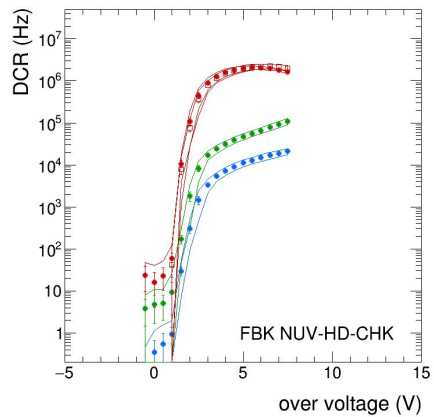
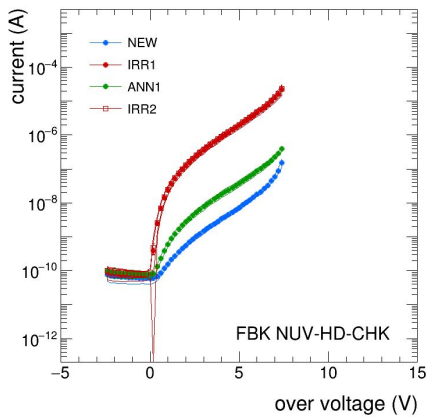
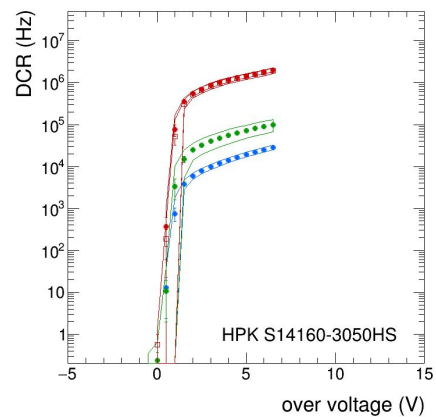
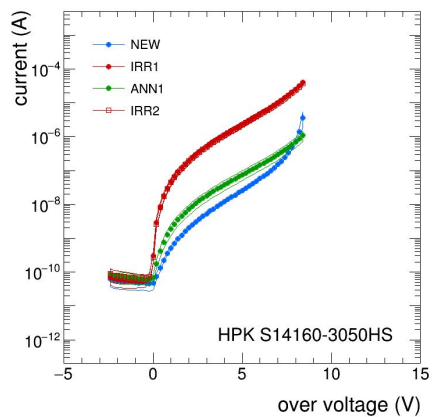
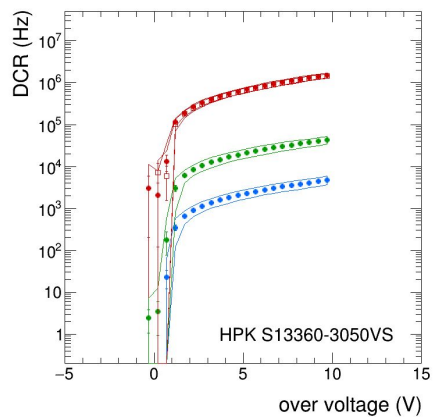
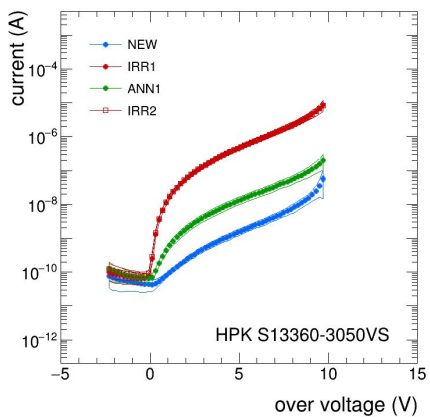
- **procedure**

- insert all boards when the oven is hot
- keep for 150 hours
- switch off and let cool down for ~ 24 hours

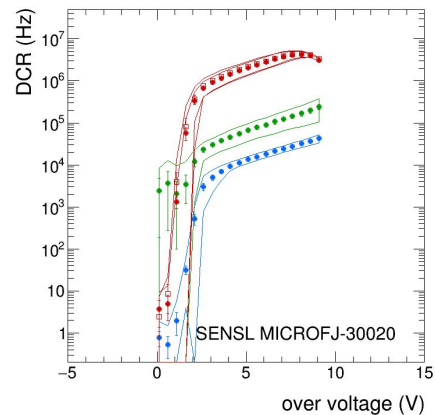
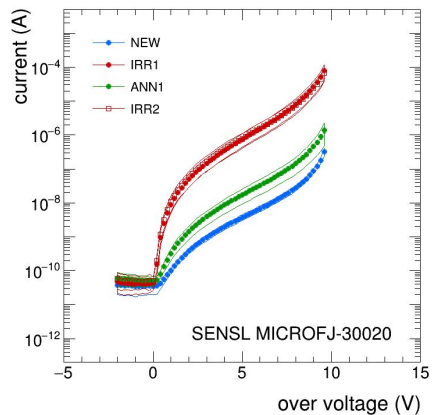
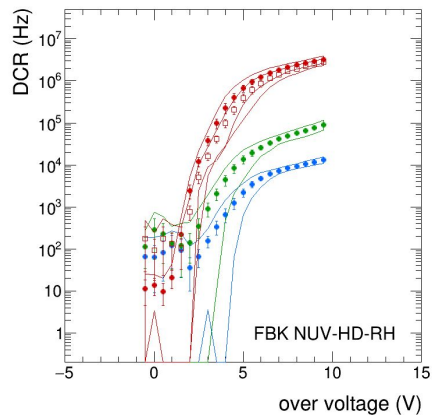
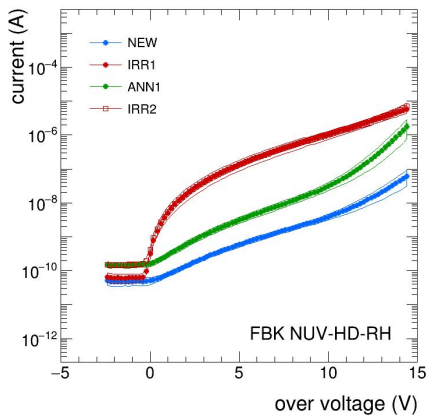
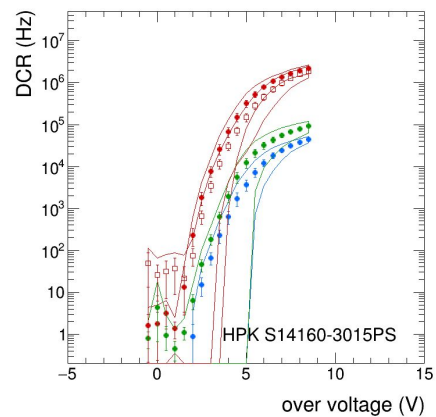
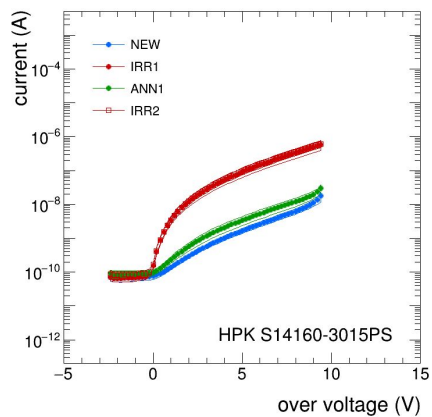
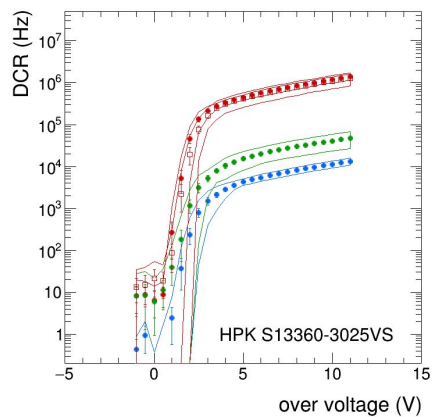
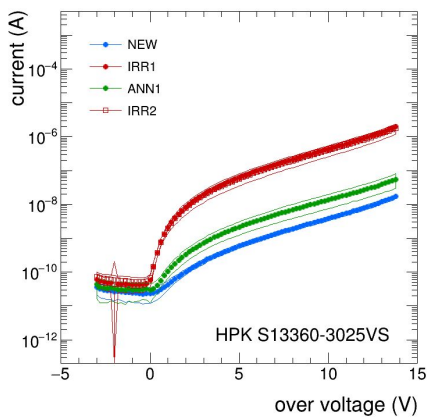




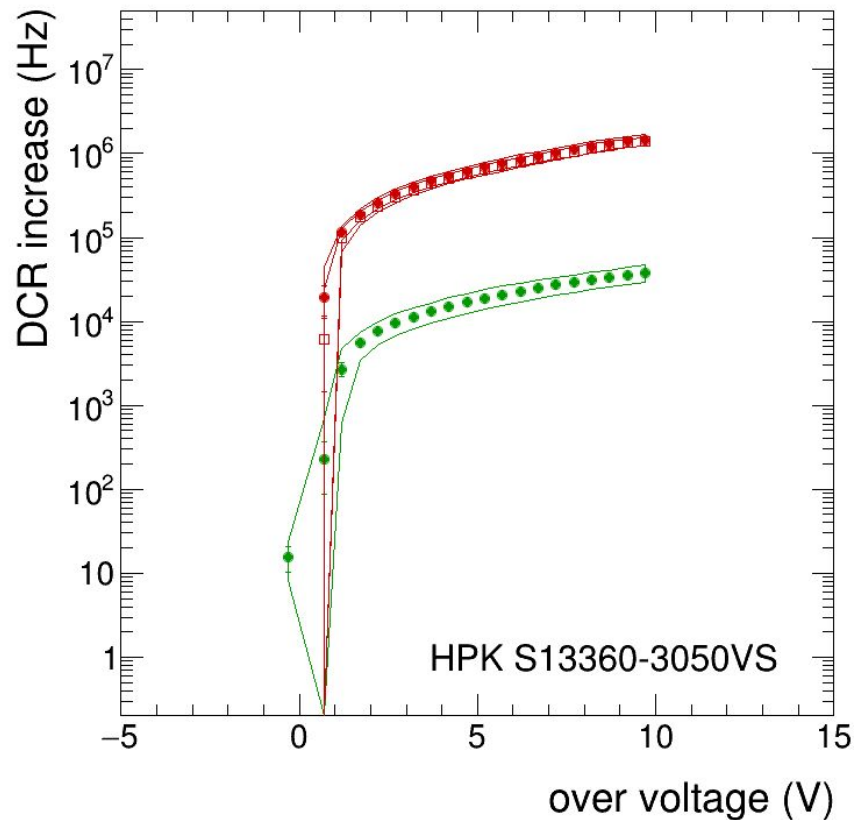
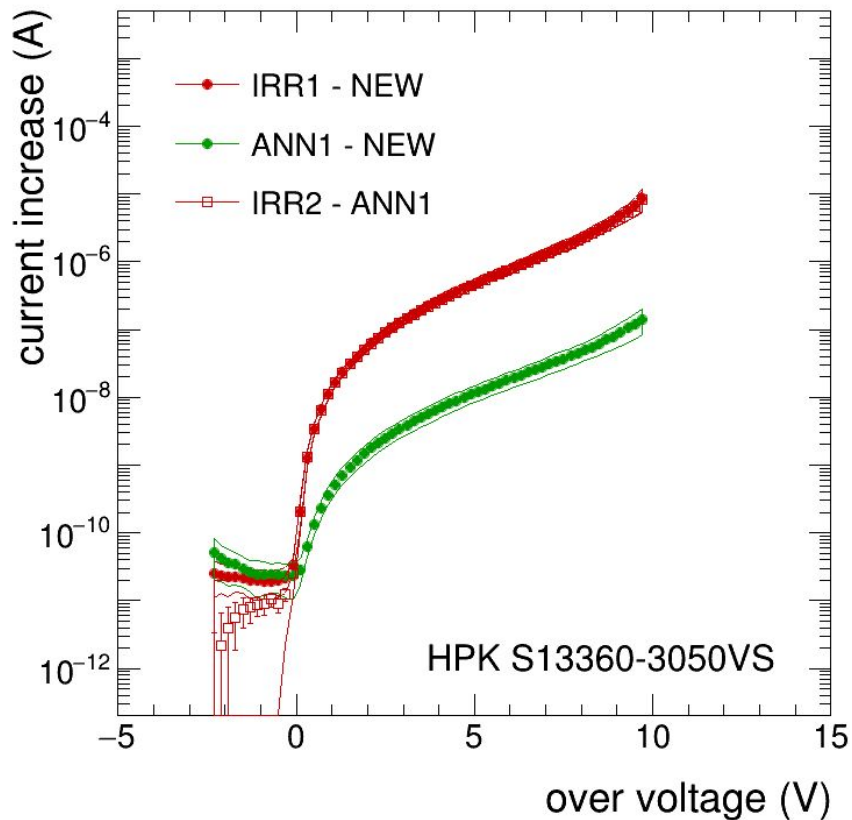
2nd irradiation shot brings currents / DCR at same level measured after 1st irradiation shot



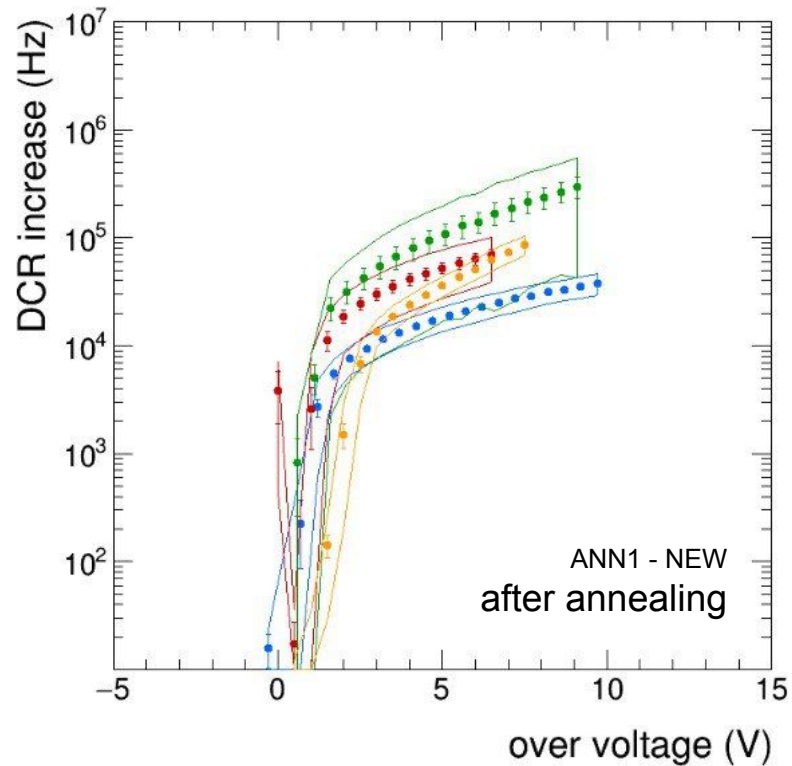
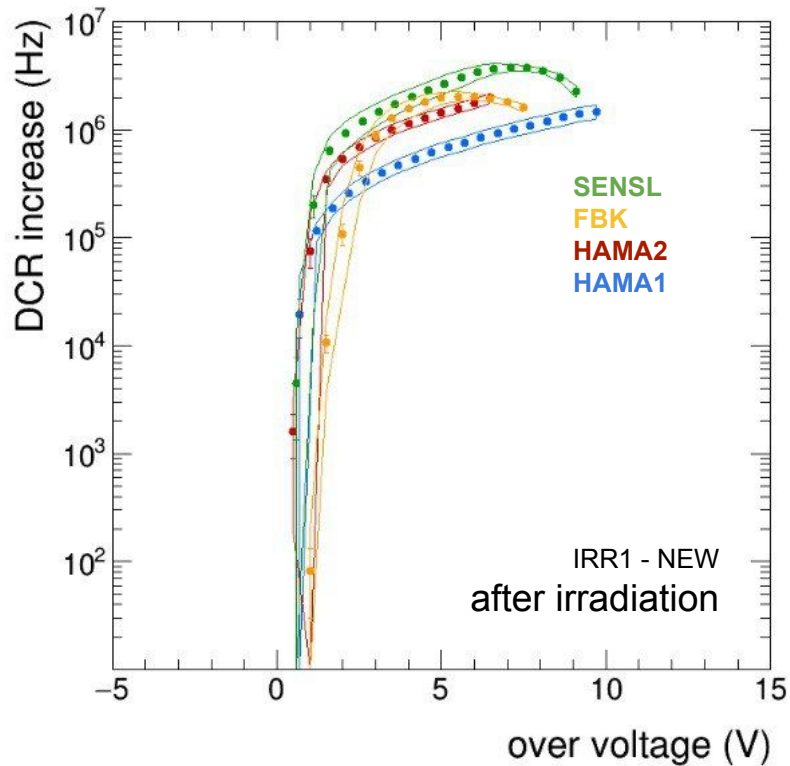
true for all sensors



true for all sensors

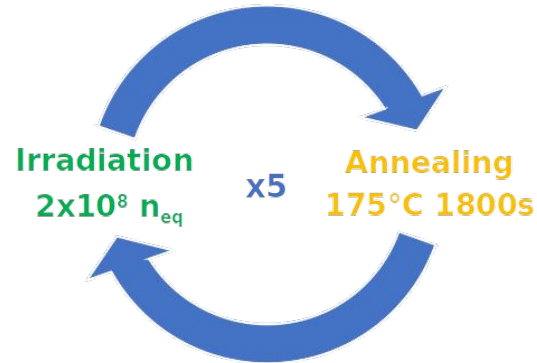
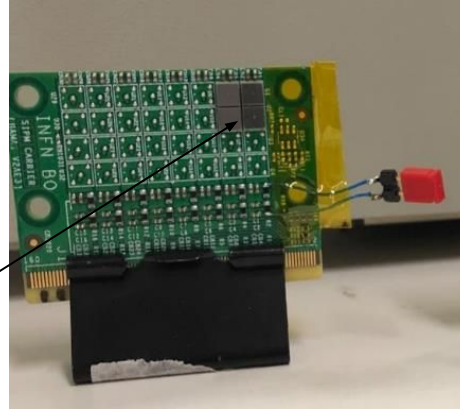


DCR (@  $V_{\text{over}} = 3 \text{ V}$ ) increases by  $\sim 350 \text{ kHz}$  after each  $10^9$  neq shot  
 residual DCR excess (@  $V_{\text{over}} = 3 \text{ V}$ ) of  $\sim 10 \text{ kHz}$  after annealing



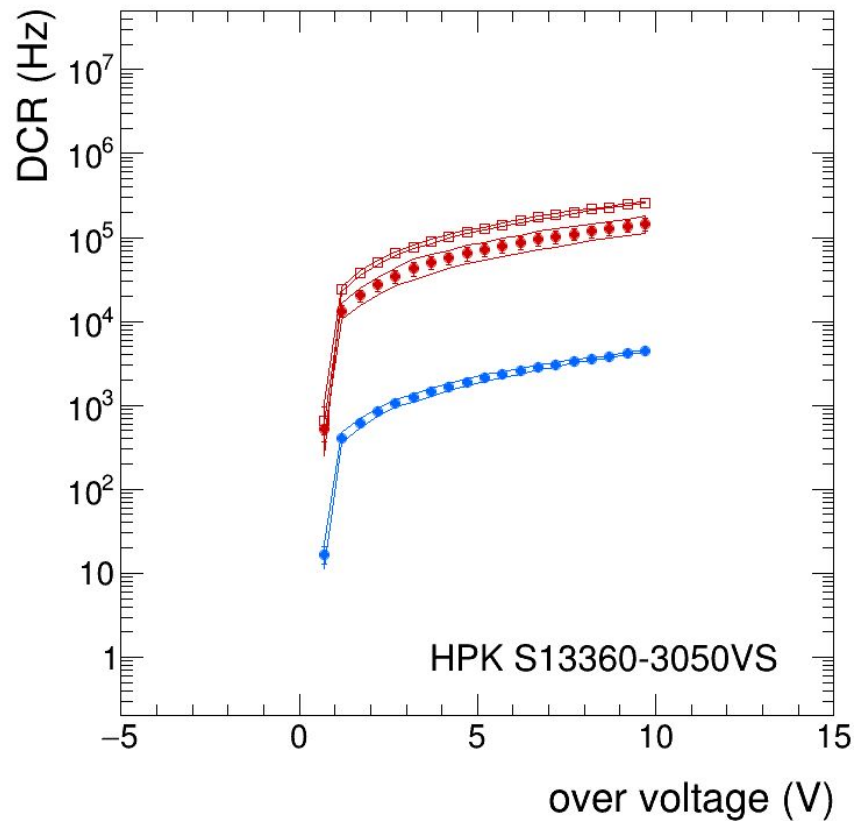
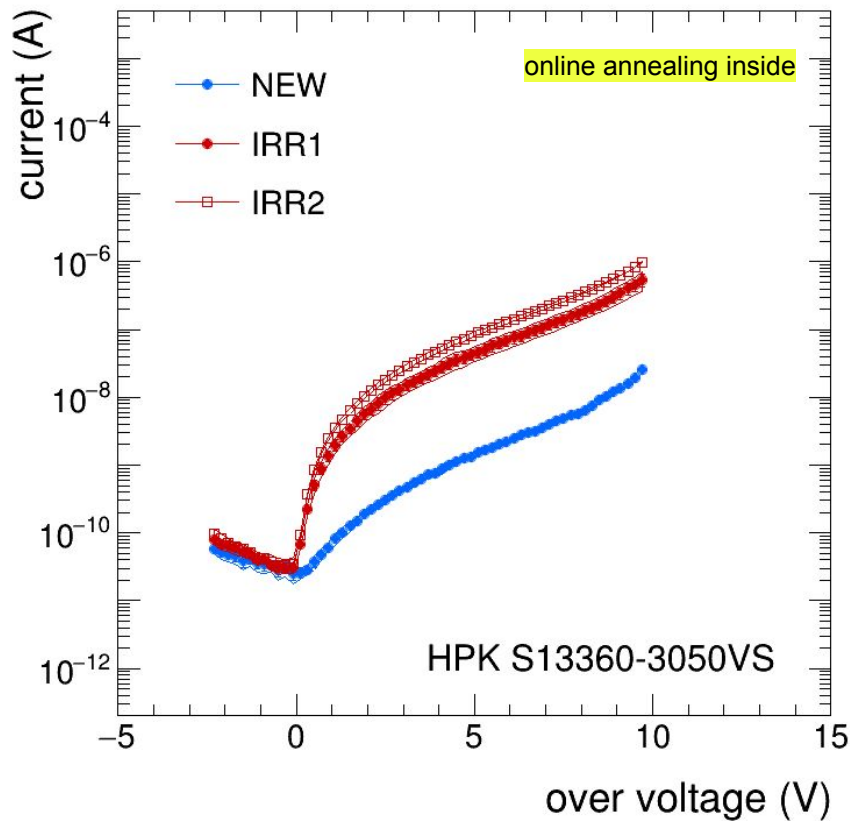
Hamamatsu S13360-3050 (HAMA1) is always the best with lowest DCR when new, increase with NIEL, residual after annealing

# Online annealing



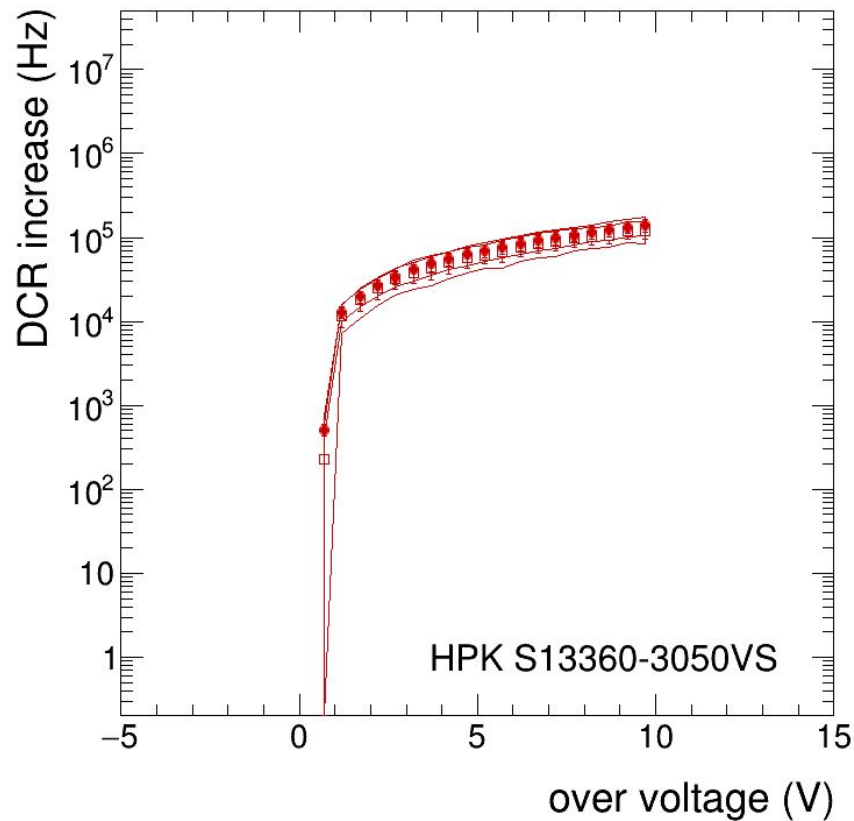
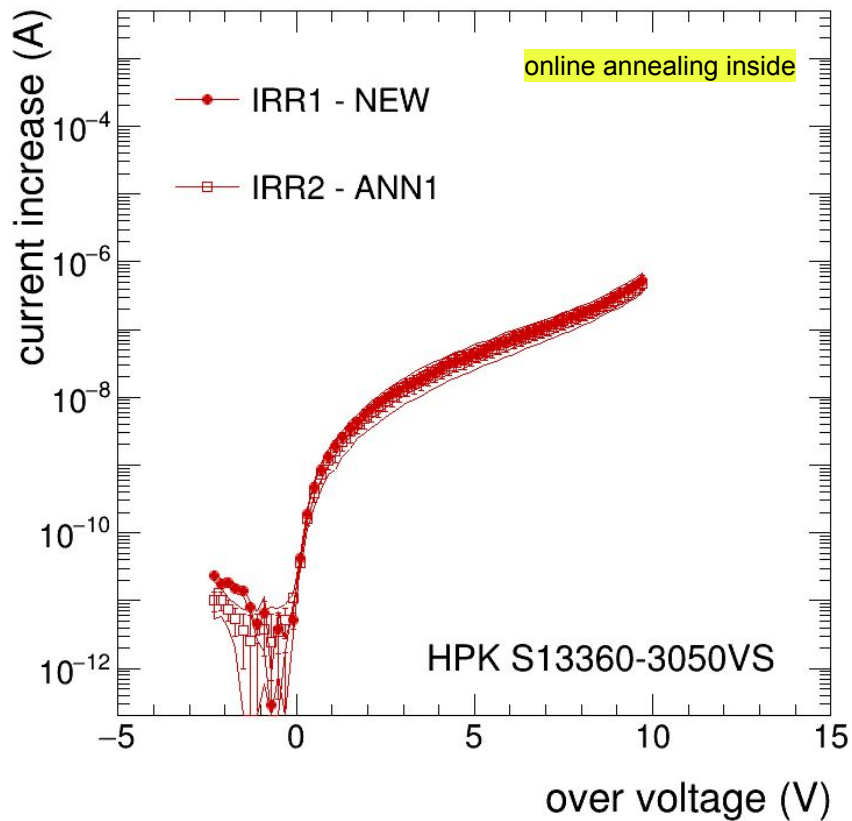
## explore solutions for in-situ annealing

- total fluence of  $10^9 n_{eq}$ 
  - delivered in 5 chunks
  - each of  $2 \times 10^8 n_{eq}$
- interleave by annealing
  - forward bias,  $\sim 1 \text{ W}$  / sensor
  - $T = 175^\circ\text{C}$ , thermal camera
  - 30 minutes
- preliminary tests
  - Hamamatsu S13360-3050



2nd irradiation shot brings currents / DCR at higher level than measured after 1st irradiation shot





DCR (@  $V_{\text{over}} = 3 \text{ V}$ ) increases by  $\sim 35 \text{ kHz}$  after each  $10^9$  neq shot  
memo: it was 350 kHz without online annealing

# Radiation damage model (HPK S13360-3050 @ $V_{over} = 3\text{ V}$ )

- **reasonable assumptions**

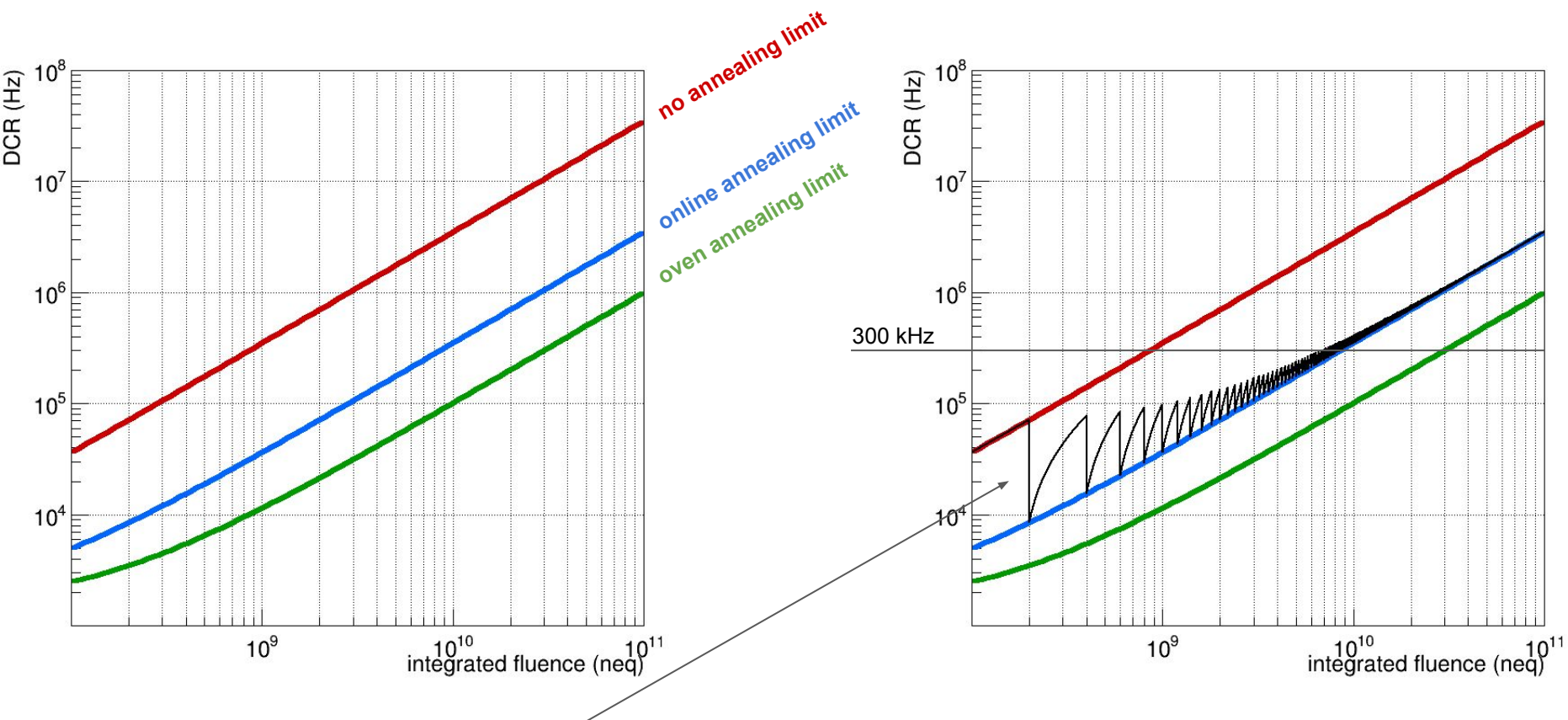
- radiation damage is additive
- does not know and care of the past damage
- annealing heals up to a certain fraction of damage, not more than that

- **numbers**

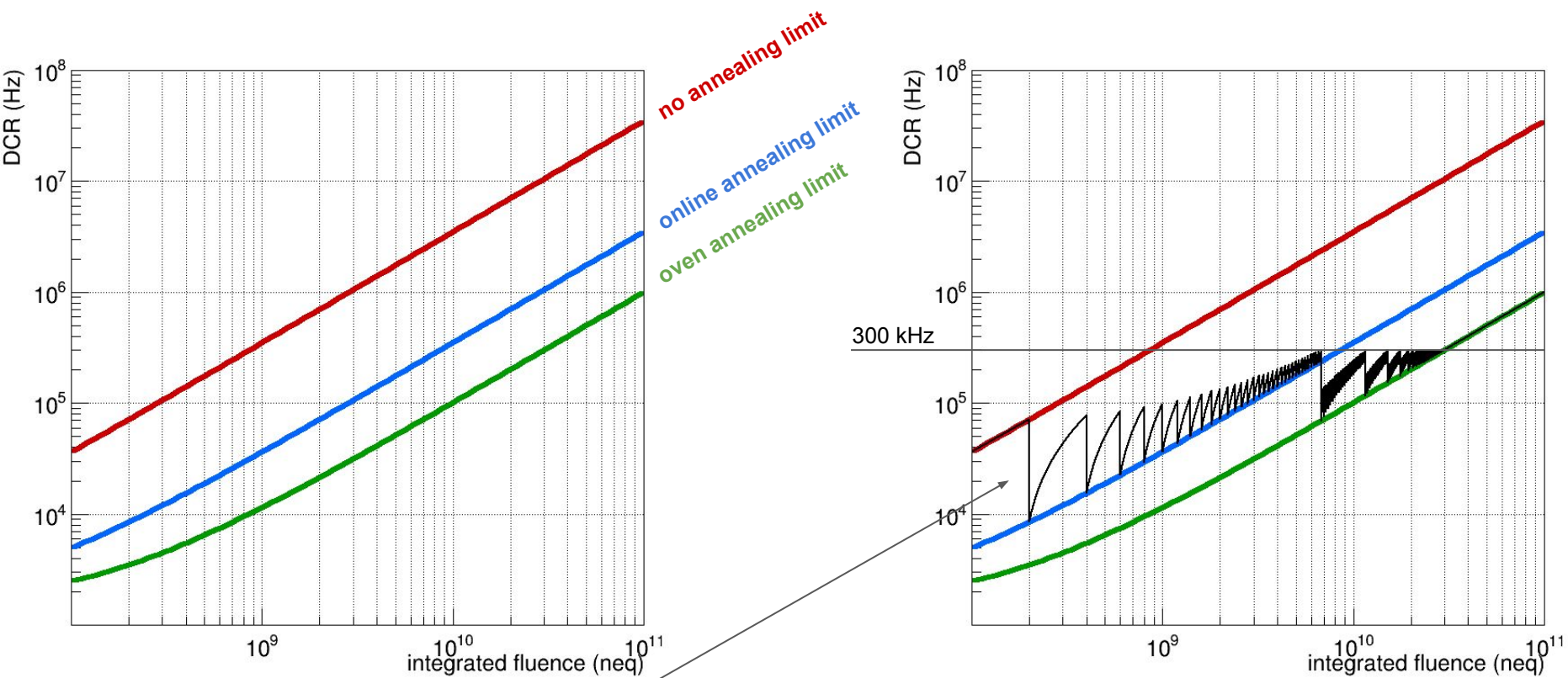
- DCR when new = 1.5 kHz
- DCR increase with radiation damage = 350 kHz /  $10^9$  neq
- DCR increase with online annealing = 35 kHz /  $10^9$  neq
- DCR residual after oven annealing = 3%

- **how it works?**

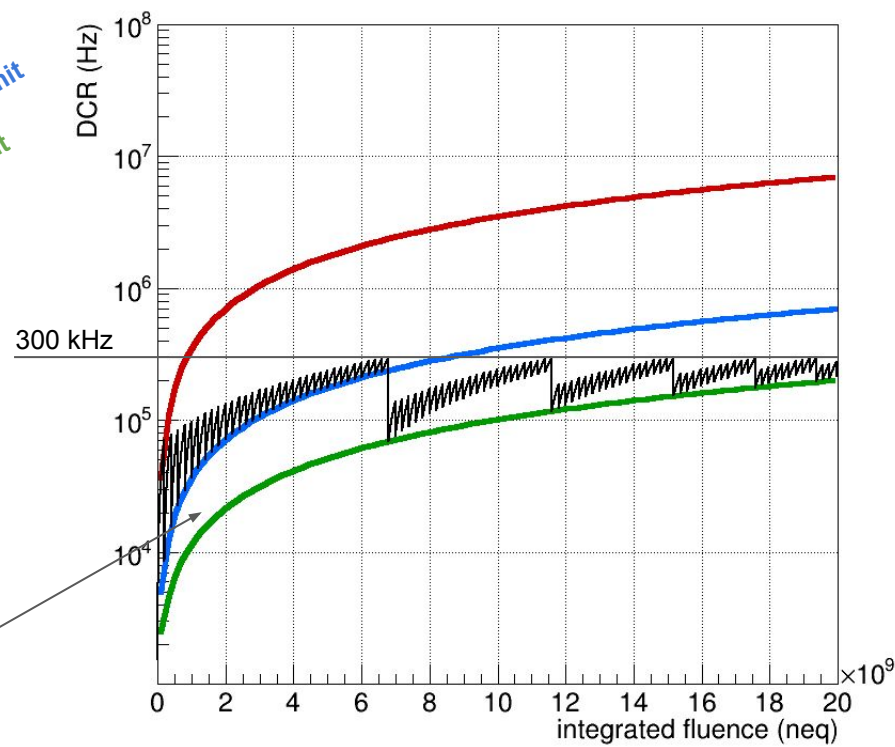
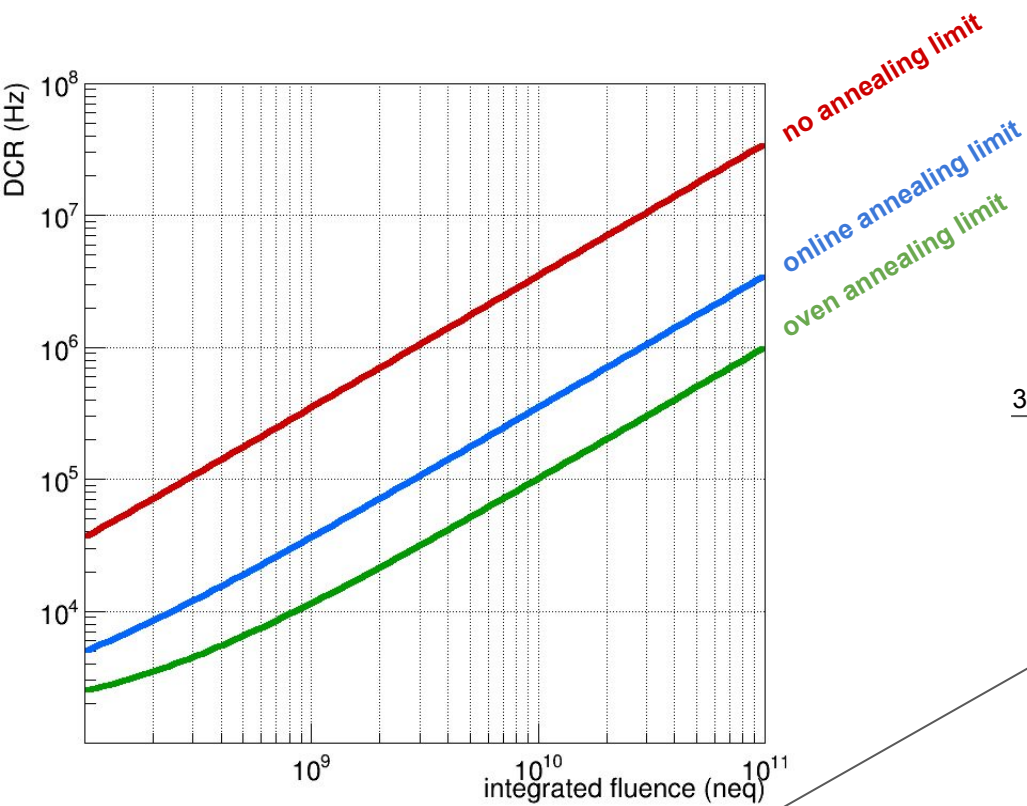
- start with DCR as new  $\rightarrow$  NEW
- add DCR with increasing radiation  $\rightarrow$  NEW + NIEL1
- heal with annealing  $\rightarrow$  NEW + x NIEL1
- add DCR with increasing radiation  $\rightarrow$  NEW + x NIEL1 + NIEL2
- heal with annealing  $\rightarrow$  NEW + x ( NIEL1 + NIEL2 )



online annealing every  $2 \cdot 10^8$  neq (500 times)



online annealing every  $2 \times 10^8$  neq (500 times)  
oven annealing when DCR > 300 kHz



online annealing every  $2 \times 10^8$  neq (500 times)  
oven annealing when DCR > 300 kHz